BUT33

56 AMPERES

NPN SILICON POWER DARLINGTON

TRANSISTOR

600 VOLTS 250 WATTS

Designer's™ Data Sheet SWITCHMODE Series NPN Silicon Power Darlington Transistors with Base-Emitter Speedup Diode

The BUT33 Darlington transistor is designed for high–voltage, high–speed, power switching in inductive circuits where fall time is critical. They are particularly suited for line operated SWITCHMODE applications such as:

- AC and DC Motor Controls
- Switching Regulators
- Inverters
- Solenoid and Relay Drivers
- Fast Turn Off Times 800 ns Inductive Fall Time at 25°C (Typ) 2.0 μs Inductive Storage Time at 25°C (Typ)
- Operating Temperature Range –65 to 200°C

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MAXIMUN	

Rating	Symbol	BUT33	Unit
Collector–Emitter Voltage	VCEO(sus)	400	Vdc
Collector–Emitter Voltage	VCEV	600	Vdc
Emitter Base Voltage	V _{EB}	10	Vdc
Collector Current — Continuous — Peak (1)	IC ICM	56 75	Adc
Base Current — Continuous — Peak (1)	I _B IBM	12 15	Adc
Free Wheel Diode Forward Current — Continuous — Peak	I _F I _{FM}	56 75	Adc
Total Power Dissipation @ $T_C = 25^{\circ}C$ @ $T_C = 100^{\circ}C$ Derate above 25°C	PD	250 140	Watts W/°C
Operating and Storage Junction Temperature Range	TJ, Tstg	-65 to +200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Мах	Unit
Thermal Resistance, Junction to Case	R _{0JC}	0.7	°C/W
Maximum Lead Temperature for Soldering Purpose 1/8" from Case for 5 Seconds	ΤL	275	°C

(1) Pulse Test: Pulse Width = 5 ms, Duty Cycle $\leq 10\%$.

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Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.





BUT33

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				
Collector–Emitter Sustaining Voltage (Table 1) ($I_C = 100 \text{ mA}, I_B = 0$)	VCEO(sus)	400	-	—	Vdc
Collector Cutoff Current (V _{CEV} = Rated Value, V _{BE(off)} = 1.5 Vdc) (V _{CEV} = Rated Value, V _{BE(off)} = 1.5 Vdc, T _C = 100°C)	ICEV			0.2 4.0	mAdc
Emitter Cutoff Current (V _{EB} = 20 V, I _C = 0)	IEBO	_	-	350	mAdc
SECOND BREAKDOWN	•				
Second Breakdown Collector Current with base forward biased	I _{S/b}		See Figure 16		
Clamped Inductive SOA with Base Reverse Biased	RBSOA		See Figure 17		
DN CHARACTERISTICS (1)	•				
DC Current Gain (I _C = 20 A, V _{CE} = 5 V) (I _C = 36 A, V _{CE} = 5 V)	hFE	30 20		_	
Collector-Emitter Saturation Voltage $(I_{C} = 20 \text{ A}, I_{B} = 1 \text{ A})$ $(I_{C} = 36 \text{ A}, I_{B} = 3.6 \text{ A})$ $(I_{C} = 44 \text{ A}, I_{B} = 4.4 \text{ A})$ $(I_{C} = 56 \text{ A}, I_{B} = 11.2 \text{ A})$	V _{CE(sat)}		 	2.0 2.5 3.0 5.0	Vdc
Base-Emitter Saturation Voltage $(I_C = 20 \text{ A}, I_B = 1 \text{ A})$ $(I_C = 36 \text{ A}, I_B = 3.6 \text{ A})$ $(I_C = 44 \text{ A}, I_B = 4.4 \text{ A})$	VBE(sat)			2.5 2.9 3.3	Vdc
Diode Forward Voltage (I _F = 44 A)	V _f	_	-	4.0	Vdc
SWITCHING CHARACTERISTICS nductive Load Clamped (Table 1)	•				•
Storage Time $T_C = 25^{\circ}C$ $I_C = 3$	36 A t _s		2.0	3.3	μs
Fall Time I _B = 3	.6 A t _f	—	0.8	1.6	μs

 $V_{BE(off)} = 5 V$

(1) Pulse Test: PW = 300 μ s, Duty Cycle $\leq 2\%$.

 $T_C = 100^{\circ}C$

See Table 1

Storage Time

Fall Time

2.2

0.8

μs

μs

t_S

t_f

TYPICAL CHARACTERISTICS





Figure 5. Thermal Response





Figure 8. Storage Time versus Forced Gain



FREE-WHEEL DIODE CHARACTERISTICS



Figure 10. Free Wheel Diode Measurements



Figure 11. Forward Voltage



The Safe Operating Area figures shown in Figures 16 and 17 are specified for the devices under the test conditiond shown.



Figure 16. Safe Operating Area



Figure 17. Reverse Bias Safe Operating Area

SAFE OPERATING AREA INFORMATION

FORWARD BIAS

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation, i.e., the transistor must not be subject to greater dissipation than the curves indicate.

The data of Figure 16 is based on $T_C = 25^{\circ}C$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C \ge 25^{\circ}C$. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 16 may be found at any case temperature by using the appropriate curve on Figure 18.

 $T_{J(pk)}$ may be calculated from the data in Figure 5. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

REVERSE BIAS

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Bias Safe Operating Area and represents the voltage current condition allowable during reverse biased turnoff. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode Figure 17 gives the RBSOA characteristics.



Figure 18. Power Derating



BUT33

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How to reach us:

USA/EUROPE: Motorola Literature Distribution; P.O. Box 20912; Phoenix, Arizona 85036. 1–800–441–2447

MFAX: RMFAX0@email.sps.mot.com – TOUCHTONE (602) 244–6609 HONG KONG: Motorola Ser

INTERNET: http://Design-NET.com



6F Seibu–Butsuryu–Center, 3–14–2 Tatsumi Koto–Ku, Tokyo 135, Japan. 03–3521–8315
HONG KONG: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852–26629298

JAPAN: Nippon Motorola Ltd.; Tatsumi-SPD-JLDC, Toshikatsu Otsuki,

